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## INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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of 1

Complete if Known				
Application Number	10/698,805			
Filing Date	October 31, 2003			
First Named Inventor	Szpak, Peter			
Art Unit	2123.			
Examiner Name	Not Yet Assigned			
Attorney Docket Number	MWS-058			

U.S. PATENT DOCUMENTS					
Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines, Where
Initials"	No.'	Number-Kind Code <sup>2</sup> ( if known)	MM-DD-YYYY	Applicant of Cited Document	Relevant Passages or Relevant Figures Appear
	A1	5,371,851	12-06-1994	Pieper, et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document  Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	

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		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T2
- CK	A2	Drongowski, et al. "A Graphical Hardware Design Language." Proceedings of the Design Automation Conference, June 12, 1988, paper 9.2, pp. 108-114.	
- COV	/A3	Lavagno, et al. "A Simulink @-based Approach to System Level Design and Architecture Selection." Proceedings of the Euromicro Conference, September 5, 2000, pp. 76-83.	
-59	/A4	May, P. "A Flexible VHDL Test Bench Architecture." Military Communications Conference, IEEE San Diego, CA, October 11, 1992, pp. 979-985.	
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Complete If Known Substitute for form 1449A/B/PTO Application Number 10/698805-Conf. #2494 INFORMATION DISCLOSURE Filing Date October 31, 2003 STATEMENT BY APPLICANT First Named Inventor Peter SZPAK 2123 Art Unit (Use as many sheets as necessary) Examiner Name Not Yet Assigned MWS-058 Sheet 1 of 1 Attorney Docket Number

U.S. PATENT DOCUMENTS						
Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines, Where	
Initials*	No.1	Number-Kind Code <sup>2</sup> ( if known)	MM-DD-YYYY	Applicant of Cited Document	Relevant Passages or Relevant Figures Appear	

FOREIGN PATENT DOCUMENTS						
Examiner	Cite	Foreign Patent Document	Publication	Name of Patentee or	Pages, Columns, Lines,	
Initiats*	No.1	Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>8</sup> (if known)	Date MM-DD-YYYY	Applicant of Cited Document	Where Relevant Passages or Relevant Figures Appear	T⁰

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FW	C1	Drongowski, Paul J., et al., "A graphical hardware design language," Proceedings of the Design Automation Conference, Anaheim, June 12-15, 1988, Proceedings of the Design Automation Conference (DAC), New York, IEEE, US, Vol. Conf. 25, 12 June 1988, pp. 108-114	
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	C4	Molson, Philippe, et al., "Accelerating intellectual property design flow using Simulink® for system on a programmable chip," Conference Record of the 35th Asilomar Conference on Signals, Systems & Computers, Pacific Grove, CA, Nov. 4-7, 2001, Asilomar Conference on Signals, Systems and Computers, New York, NY: EEE, US, Vol. 1 of 2, Conf. 35, 4 November 2001, pp. 454-457	
	C5	Mrad, Fouad, et al., "Real-Time Control of Free-Standing Cart-mounted Inverted Pendulum using LabVIEW RT," Proceedings of World Congress on Industrial Applications of Electrical Energy and 35th IEEE-IAS Annual Meeting, Vol. 2, 8 October 2000, pp. 1291-1298	
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(XX	C7	Skelly, G.N., et al., "A LabVIEW Approach to Instrumentation for the TFTR Bumper Limiter Alignment Project," Proceedings of the IEEE/NPSS Symposium on Fusion Engineering, San Diego, Sept. 30 - Oct. 3, 1991, New York, IEEE, US, Vol. 2 Symp 14, 30 Sept. 1991, pp. 765-768	
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